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(54) **METHOD OF MANUFACTURING A DISPLAY DEVICE HAVING A DRIVER CIRCUIT ATTACHED TO A DISPLAY SUBSTRATE**

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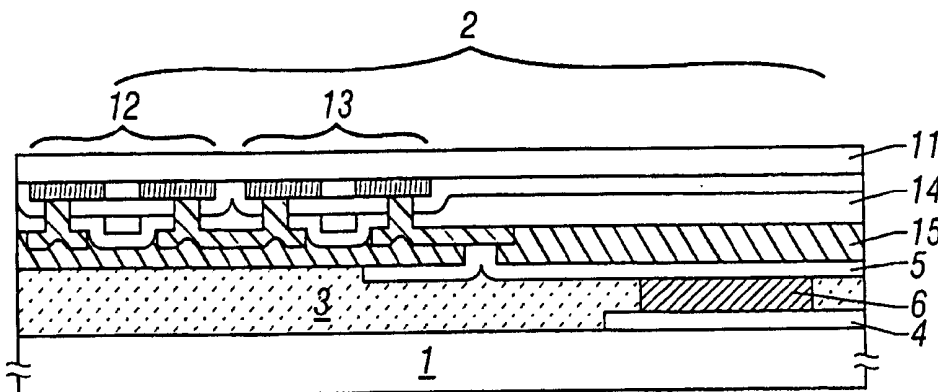
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#### (57) **ABSTRACT**

A method of fabricating a driver circuit for use with a passive matrix or active matrix electrooptical display device such as a liquid crystal display. The driver circuit occupies less space than heretofore. A circuit (stick crystal) having a length substantially equal to the length of one side of the matrix of the display device is used as the driver circuit. The circuit is bonded to one substrate of the display device, and then the terminals of the circuit are connected with the terminals of the display device. Subsequently, the substrate of the driver circuit is removed. This makes the configuration of the circuit much simpler than the configuration of the circuit heretofore required by the TAB method or COG method, because conducting lines are not laid in a complex manner. The driver circuit can be formed on a large-area substrate such as a glass substrate. The display device can be formed on a lightweight material having a high shock resistance such as a plastic substrate. Hence, a display device having excellent portability can be obtained.

**27 Claims, 5 Drawing Sheets**



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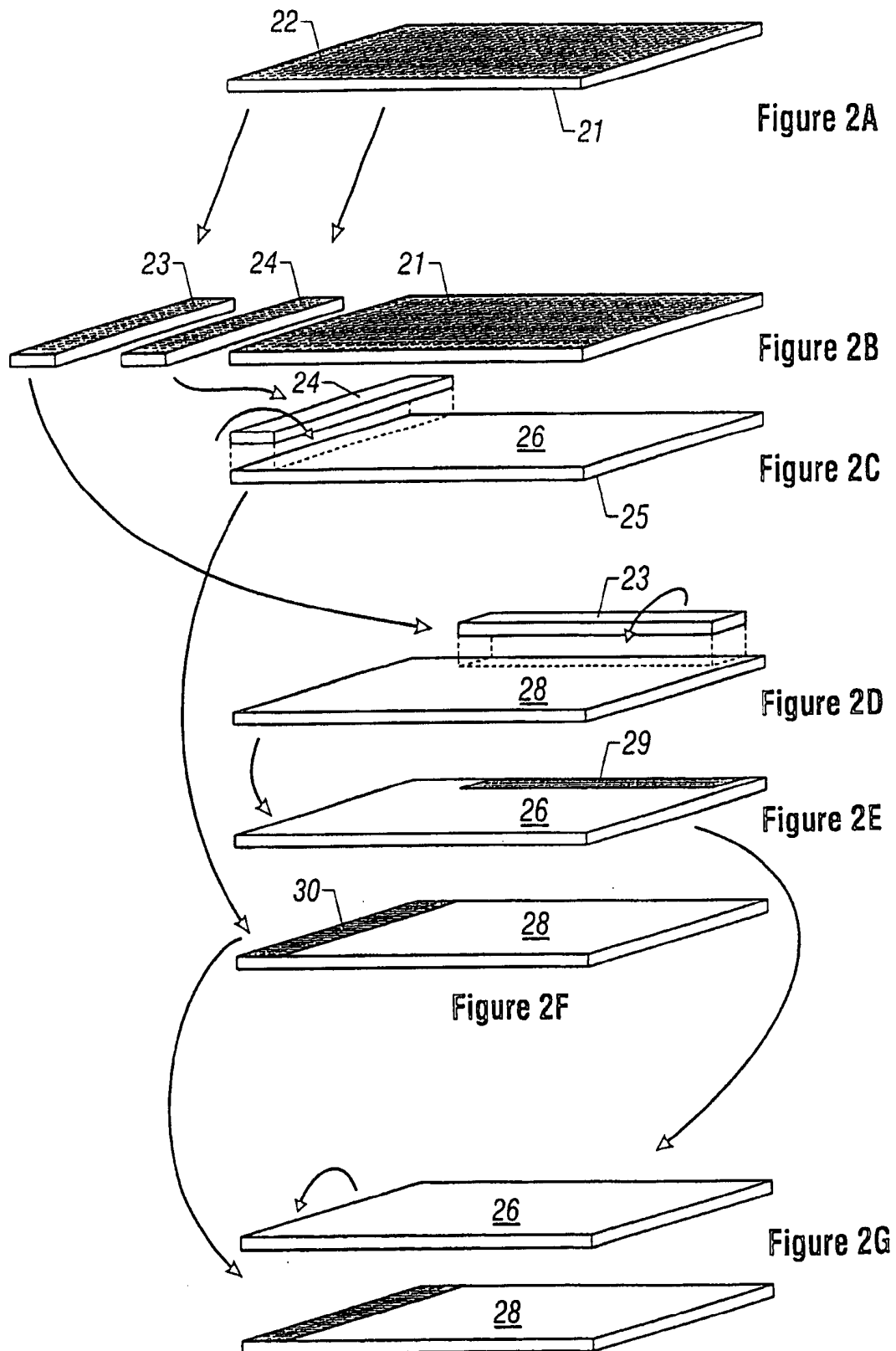
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### Figure 1D



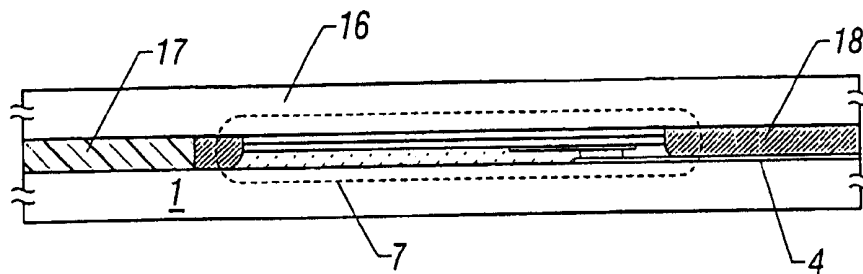


Figure 3

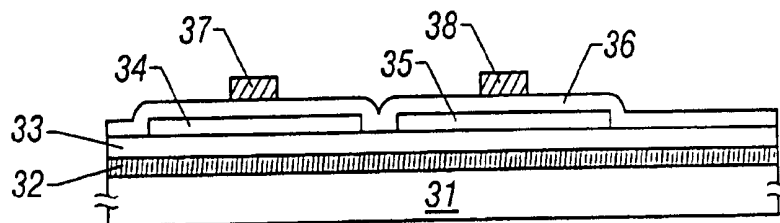


Figure 4A

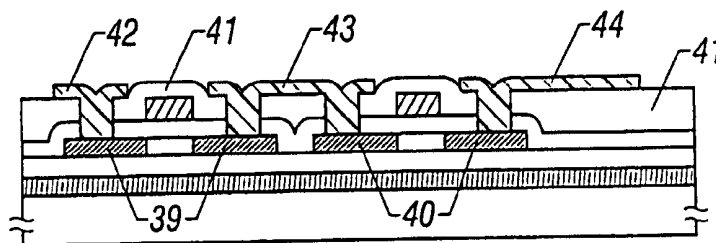


Figure 4B

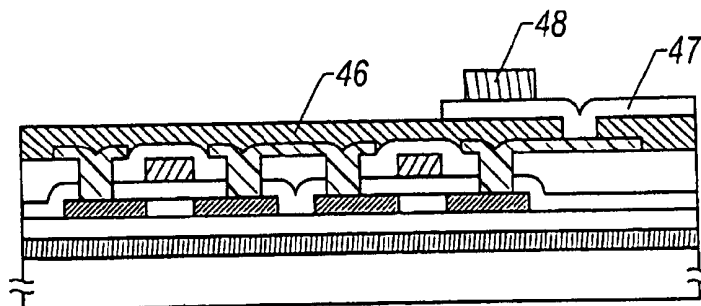


Figure 4C

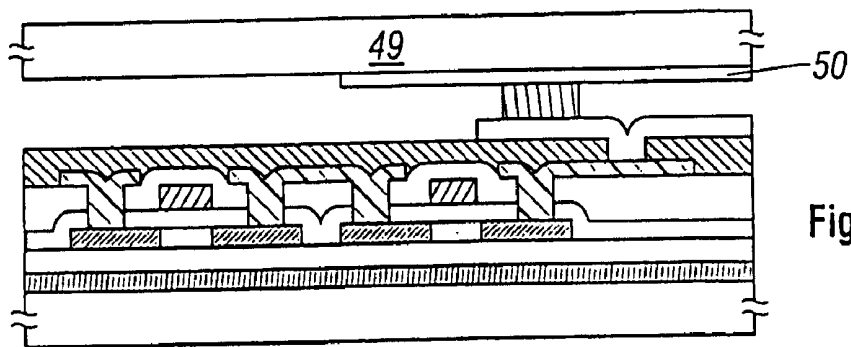


Figure 5A

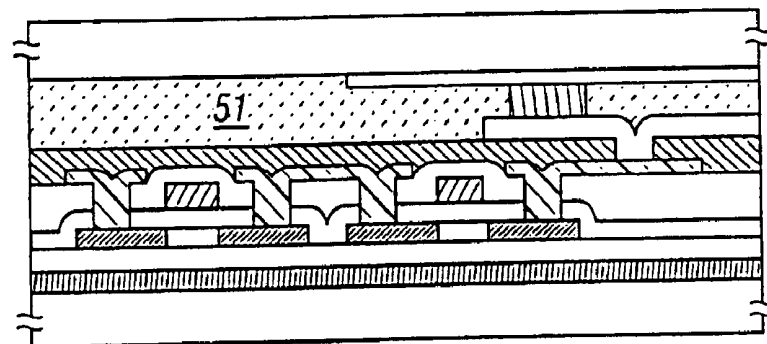


Figure 5B

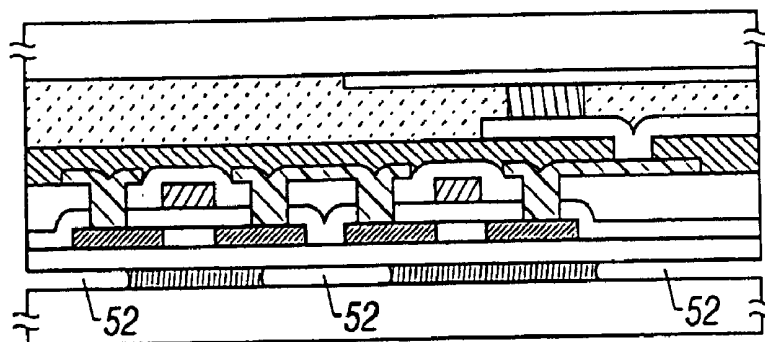


Figure 5C

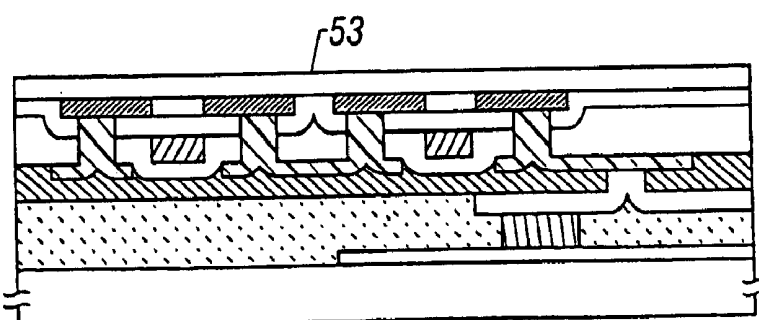
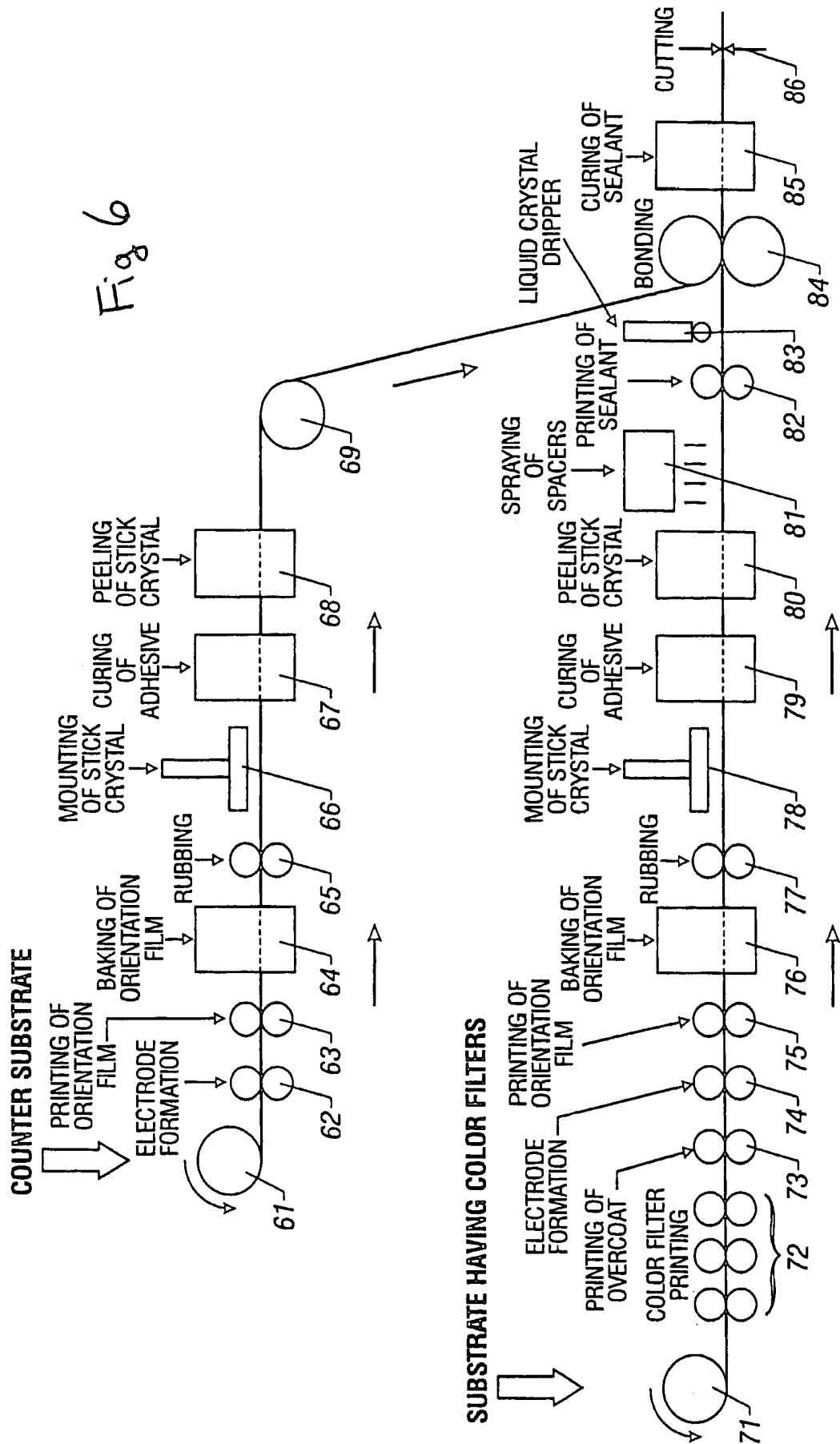


Figure 5D



# METHOD OF MANUFACTURING A DISPLAY DEVICE HAVING A DRIVER CIRCUIT ATTACHED TO A DISPLAY SUBSTRATE

This is a continuation of U.S. application Ser. No. 09/062,873, filed Apr. 20, 1998, now U.S. Pat. No. 6,118,502, which is a continuation of U.S. application Ser. No. 08/611,336, filed Mar. 8, 1996, now U.S. Pat. No. 5,757,456, which claims priority from Japanese Patent applications 7-86457 filed Mar. 16, 1995 and 7-79708 filed Mar. 10, 1995.

## BACKGROUND OF THE INVENTION

### 1. Field of the Invention

The present invention relates to a passive matrix or active matrix display such as a liquid crystal display and, more particularly, to a fashionable display device in which the ratio of the area of the display portion to the area of the substrates of the display device is increased by effectively mounting a driver semiconductor integrated circuit.

### 2. Description of the Related Art

Passive matrix type and active matrix type constructions are known as matrix display devices. In the passive matrix type, a number of stripe-shaped conducting lines (row lines) made of a transparent conductive film or the like are arrayed in a certain direction on a first substrate. On a second substrate, similar stripe-shaped conducting lines (column lines) are arrayed in a direction substantially perpendicular to the conducting lines on the first substrate. Both substrates are so arranged that the conducting lines on them intersect each other.

An electrooptical material such as a liquid crystal material whose transparency, reflectivity, or scattering performance is varied by a voltage, current, or the like is positioned between both substrates. If a voltage or current is applied between an addressed row line on the first substrate and an addressed column line on the second substrate, then the transparency, reflectivity, or scattering performance at the intersection can be set to a desired value. In this way, the display device can be matrix driven.

In the active matrix construction, row and column lines are formed on the first substrate by multilayer metallization techniques. Pixel electrodes are formed at the intersections of the row and column lines. An active device such as a thin-film transistor (TFT) is formed at each pixel electrode to control the potential or current in the pixel electrode. A transparent conductive film is also formed on the second substrate. Both substrates are so arranged that the pixel electrodes on the first substrate are located opposite to the transparent conductive film on the second substrate.

In either type, the substrates are selected according to the used process. For example, the passive matrix construction needs no complex process steps except for steps where the transparent conductive films are formed and etched into row and column conducting line patterns. The substrates of this passive matrix type may be made from plastic, as well as from glass. On the other hand, to manufacture the active matrix construction, a relatively high-temperature film formation step is required. Furthermore, the active matrix type must keep out mobile ions such as sodium ions. The substrates of the active matrix type must be made of glass containing a quite low concentration of alkali.

In any type of prior art matrix display device excluding special constructions, a semiconductor integrated circuit (peripheral driver circuit) for driving the matrix is required

to be mounted. In the past, this has been done by tape automated bonding (TAB) or chip on glass (COG). However, the matrix construction contains as many as several hundreds of rows. Therefore, the integrated circuit has a very large number of terminals. The corresponding driver circuit takes the form of a rectangular IC package or semiconductor chip. To connect these terminals with the conducting lines on the substrates, it is necessary to lay the conducting lines in a complex manner. As a consequence, the ratio of the area of the peripheral portion, or non-display portion, to the area of the display portion is not negligibly small.

A method for solving this problem is disclosed in Japanese Patent Laid-Open No. 14880/1995, and consisting of forming a driver circuit on an elongated substrate (referred to as a stick or stick crystal) having a length substantially equal to one side of the matrix construction and connecting the driver circuit with the terminal portion of the matrix. This arrangement is permitted, because a width of about 2 mm suffices for the driver circuit. Therefore, almost the whole area of the substrate can be made a viewing screen.

Of course, in this case, where the matrix has a large area, it is impossible to form a circuit on a silicon wafer. Consequently, it is necessary to form the circuit on a glass substrate or the like. Hence, active devices used in semiconductor devices are TFTs.

However, where a stick crystal is employed, the thickness of the substrate of the driver circuit has been an obstacle to miniaturization of the whole display device. For example, where the display device should be made thinner, the thickness of the substrate is allowed to be set to 0.3 mm by optimizing the kind of the substrate and the manufacturing steps. However, because of the strength necessary during manufacturing steps, it is difficult to reduce the thickness of the stick crystal below 0.5 mm. As a result, where two substrates are bonded together, the stick crystal protrudes as long as 0.2 mm or more.

Furthermore, if the stick crystal differs from the substrates of the display device in kind, then defects may be produced in the circuit because of the difference in coefficient of thermal expansion and for other causes. Especially, where a plastic substrate is used in a display device, this problem is conspicuous, because poor heat resistance of plastics makes it substantially impossible to use a plastic substrate as a stick crystal substrate.

Moreover, where the kind of the substrate supporting the stick crystal is different from the kind of the substrates of the display device, other known methods are used to circumvent the above-described problem. In one known method, a semiconductor integrated circuit having TFTs is fabricated on other support substrate. Then, the circuit is peeled off and adhesively bonded to another substrate. In another known method, the original support substrate is removed after adhesively bonding the circuit to another substrate. This technique is generally known as silicon-on-insulator (SOI) technique.

However, when the support substrate is removed, the semiconductor integrated circuit is often damaged, thus deteriorating the manufacturing yield.

## SUMMARY OF THE INVENTION

It is an object of the present invention to provide a smaller display device of reduced weight by solving the foregoing problems with the stick crystal.

It is another object of the invention to provide a method of fabricating display devices with a high production yield by solving the aforementioned problems.



The present invention is characterized in that the driver circuit portion of a display device is made thinner by mechanically bonding a semiconductor integrated circuit equivalent to a stick crystal to a substrate for the display device, making electrical connections, and then removing only the substrate from the stick crystal. In this construction, stress induced by deformation caused by thermal expansion of the substrate is applied uniformly to the whole circuit. Therefore, the stress is prevented from being concentrated in certain portions; otherwise it would be inevitable that defects are produced.

Essentially, the present invention lies in a display device comprising a first substrate and a second substrate having a transparent conductive film on its surface. Conducting lines are formed on the first substrate. The first substrate has an elongated semiconductor integrated circuit which is electrically connected with the conducting lines and has TFTs. The transparent conductive film on the second substrate faces the surface of the first substrate on which the conducting lines are formed. The length of the semiconductor integrated circuit is roughly equal to the length of one side of the viewing surface, or the matrix, of the display device, in the same way as the stick crystal described in the above-cited Japanese Patent Laid-Open No. 14880/1995. The semiconductor integrated circuit is first fabricated on another substrate. The integrated circuit is peeled off and mounted on the first substrate.

In the case of the passive matrix type, the display device comprises a first substrate having an elongated first semiconductor circuit and a second substrate having a second semiconductor integrated circuit. A plurality of first conducting lines extending in a first direction are formed from a transparent conductive film on the first semiconductor integrated circuit. The first semiconductor integrated circuit is connected with the first conducting lines, has TFTs, and extends in a second direction substantially perpendicular to the first direction. The second substrate has second conducting lines which are formed from a transparent conductive film and extend in the second direction. The second semiconductor integrated circuit is connected with the second conducting lines, has TFTs, and extend in the first direction. The first and second substrates are so arranged that the first conducting lines are located opposite to the second conducting lines. The first and second semiconductor integrated circuits are obtained by fabricating them on other substrates, peeling the integrated circuits off, and bonding them to their respective substrates.

In the case of an active matrix type, the display device comprises a first substrate having a first and a second semiconductor integrated circuits and a second substrate having a transparent conductive film on its surface. A plurality of first conducting lines extending in a first direction are formed on the first substrate. The first semiconductor integrated circuit is connected with the first conducting lines, has TFTs, and extend in a second direction substantially perpendicular to the first direction. A plurality of second conducting lines extending in the second direction are formed also on the first substrate. The second semiconductor integrated circuit is connected with the second conducting lines, has TFTs, and extends in the first direction. The first and second substrates are so arranged that the first and second conducting lines on the first substrate are opposite to the transparent conductive film on the second substrate. The first and second semiconductor integrated circuits are obtained by fabricating them on other substrates, peeling the integrated circuits off, and mounting them to the first substrate.

The method consisting of forming a semiconductor integrated circuit having TFTs on other substrate, peeling off the circuit, and bonding the circuit to a further substrate (alternatively, the original substrate is removed after bonding to another substrate) is generally known as one of SOI (silicon-on-insulator) techniques and described in Japanese Patent Laid-Open No. 504139/1994. Also, other well-known techniques can be used.

The step for peeling a semiconductor integrated circuit from its support substrate needs the most advanced technique. The present invention is characterized in that when the semiconductor integrated circuit is peeled from the support substrate, a gas containing a halogen, especially halogen fluoride, is used.

A halogen fluoride is given by a chemical formula  $XF_n$ , where X is a halogen other than fluorine and n is an integer. It is known that halogen fluorides include chlorine monofluoride (ClF), chlorine trifluoride (ClF<sub>3</sub>), bromine monofluoride (BrF), bromine trifluoride (BrF<sub>3</sub>), iodine monofluoride (IF), and iodine trifluoride (IF<sub>3</sub>).

A halogen fluoride is characterized in that it etches silicon even under a non-plasma state but does not etch silicon oxide at all. Since it is not necessary to use a plasma, the circuit is not destroyed by plasma damage. This effectively contributes to an improvement in the production yield. Furthermore, the etching selectivity between silicon oxide and silicon is quite high. This is advantageous in that neither the circuit nor the elements are destroyed.

In the present invention, a peeling layer consisting principally of silicon is formed on a support substrate. A semiconductor integrated circuit coated with silicon oxide is formed on the peeling layer. As mentioned above, silicon is etched by a halogen fluoride without using a plasma. Other gases containing a halogen such as carbon tetrafluoride (CF<sub>4</sub>) and nitrogen trifluoride (NF<sub>3</sub>) etch silicon under a plasma condition and so they can be used for the invention.

Accordingly, by placing the support substrate either within a gas containing a halogen such as a halogen fluoride or within a plasma, the peeling layer is peeled from the support substrate. As a consequence, the semiconductor integrated circuit can be peeled off.

An example of a display device according to the present invention is shown in FIGS. 1(A)–1(D) in cross section. FIG. 1(A) depicts the device with a relatively small magnification. The left side of this figure shows a driver circuit portion 7 having a semiconductor integrated circuit 2. The right side shows a matrix portion 8. A conducting line pattern 4 is formed from a transparent conductive film on a substrate 1. A bump 6 is made of gold or other similar material. The semiconductor integrated circuit 2 has a thickness substantially equal to the thickness of TFTs. The integrated circuit 2 has a connector portion having an electrode 5 made of a conductive oxide whose contact resistance is not varied if it is oxidized. The electrode 5 is brought into contact with the bump 6. A resin 3 is injected between the semiconductor integrated circuit 2 and the substrate 1 to mechanically hold the components (FIG. 1(A)).

FIG. 1(B) is an enlarged view of the contact portion surrounded by the dotted line in FIG. 1(A). It is to be noted that like components are indicated by like reference numerals in various figures. FIG. 1(C) is an enlarged view of the portion surrounded by the dotted line in FIG. 1(B). The semiconductor integrated circuit includes an N-channel TFT 12 and a P-channel TFT 13 which are sandwiched by a buffer dielectric film 11 and an interlayer dielectric layer 14

and a passivation film **15** made of silicon nitride or the like (FIGS. **1(B)** and **1(C)**).

When a semiconductor integrated circuit is formed, the buffer film **11** is normally made of silicon oxide. However, sufficient moisture resistance cannot be obtained only with this scheme. Therefore, a passivation film must be formed on the buffer film. If the semiconductor circuit and its contact portion are thinner than the spacing between the substrates of the device as shown in FIG. **3**, then it is possible to form a counter substrate **16** on the circuit. In this case, the outer side of the driver circuit portion **7** is sealed with a sealing material **17** such as epoxy resin, in the same way as the manufacture of a liquid crystal device as disclosed in Japanese Patent Laid-Open No. 66413/1993. The gap between the substrates **1** and **16** is filled with a liquid crystal material **18** and so mobile ions do not intrude into the gap from the outside. Hence, any special passivation film is not required (FIG. **3**).

The contact portion can use a bump as described above. Another method is illustrated in FIG. **1(D)**. That is, conductive particles **9** such as particles of gold are diffused into the contact portion to provide electrical contact. The diameter of the particles is slightly greater than the spacing between the semiconductor integrated circuit **2** and the substrate **1** (FIG. **1(D)**).

The sequence for fabricating this display device which is of the passive matrix type is shown in FIGS. **2(A)–2(G)**. First, a number of semiconductor integrated circuits **22** are formed on an appropriate substrate **21** (FIG. **2(A)**).

The resulting laminate is cut to form stick crystals **23** and **24**. The electrical characteristics of the obtained stick crystals **23** and **24** may be checked before the next manufacturing step is effected, to judge whether the crystals are acceptable or rejected (FIG. **2(B)**).

Then, the surfaces of the stick crystals **23** and **24** on which the circuits are formed are bonded to surfaces **26** and **28** of separate substrates **25** and **27**, respectively. Conducting line patterns are formed from transparent conductive films on the surfaces **26** and **28**. Electrical connections are made (FIGS. **2(C)** and **2(D)**).

Subsequently, the stick drivers **23** and **24** are peeled from their respective substrates by SOI techniques or by processing with a gas containing a halogen. In this way, only semiconductor integrated circuits **29** and **30** are left on the surfaces **26** and **28**, respectively, of the substrates (FIGS. **2(E)** and **2(F)**).

Finally, the laminates obtained in this manner are made to face each other. As a result, a passive matrix display is derived. A surface **26** faces away from the surface **26**. That is, no conducting line pattern is formed on the surface **26** (FIG. **2(G)**).

In the above example, the row stick crystal (i.e., the stick crystal for a driver circuit for driving row lines) and the column stick crystal (i.e., the stick crystal for a driver circuit for driving column lines) are extracted from the same substrate **21**. Of course, they may be extracted from separate substrates.

The example shown in FIGS. **2(A)–2(G)** is a passive matrix display. Obviously, the invention can be similarly applied to an active matrix display. In the illustrated examples given below, each substrate is made of a filmy material.

Other objects and features of the invention will appear in the course of the description thereof, which follows.

#### BRIEF DESCRIPTION OF THE DRAWINGS

FIGS. **1(A)–1(D)** are cross-sectional views of a display device according to the present invention;

FIGS. **2(A)–2(G)** are exploded perspective views of another display device according to the invention, schematically illustrating a method of fabricating the device;

FIG. **3** is a cross-sectional view of a further display device according to the invention;

FIGS. **4(A)–4(C)** are cross-sectional views of a stick crystal used for manufacturing steps according to the invention;

FIGS. **5(A)–5(D)** are cross-sectional views, illustrating steps for bonding a stick crystal to a substrate; and

FIG. **6** is a schematic view of a system for fabricating filmy liquid crystal devices in succession.

#### DESCRIPTION OF THE PREFERRED EMBODIMENTS

##### EXAMPLE 1

Manufacturing steps for fabricating one substrate of a passive matrix liquid crystal display are briefly described now. The present example is described by referring to FIGS. **4(A)–4(C)** and **5(A)–5(D)**. Steps for forming a driver circuit on a stick crystal are schematically shown in FIGS. **4(A)–4(C)**. Steps for mounting the stick crystal on the substrate of the liquid crystal display are schematically shown in FIGS. **5(A)–5(D)**.

First, a silicon film having a thickness of 3000 Å was deposited as a peeling layer **32** on a glass substrate **31**. Since the silicon film becoming the peeling layer **32** is etched away when circuitry and a substrate formed on the silicon film are separated, the quality of the silicon film will present almost no problems. Therefore, the silicon film may be deposited by a method which permits mass production. Furthermore, the silicon film may be either amorphous or crystalline in character.

The glass substrate may be made of Corning 7059 glass, Corning 1737 glass, NH Technoglass NA45, NH Technoglass NA35, Nippon Denki Glass OA2, other non-alkali or low-alkali glass, or quartz glass. Where quartz glass is used, the cost poses a problem. In the present invention, however, the area of the substrate used in one liquid crystal display is quite small and so the cost per device is sufficiently low.

A silicon oxide film was deposited as a buffer film **33** having a thickness of 5000 Å on the peeling layer **32**. Sufficient care must be taken in fabricating the buffer film **33** from silicon oxide. Islands **34** and **35** of crystalline silicon region were formed by a well-known method. The thickness of the islands of crystalline silicon region greatly affects the required semiconductor characteristics. Generally, it was desired to make the thickness smaller. In the present example, the thickness was 400–600 Å.

Where crystalline silicon is obtained, laser annealing (i.e., amorphous silicon is illuminated with intense light such as laser light) or solid-phase epitaxy using thermal annealing is employed. Where solid-phase epitaxy is utilized, if a catalytic element such as nickel is added to the silicon as disclosed in Japanese Patent Laid-Open No. 244104/1994, then the crystallization temperature can be lowered, and the annealing time can be shortened. Furthermore, as described in Japanese Patent Laid-Open No. 318701/1994, once silicon is crystallized by solid-phase epitaxy, it may be laser-annealed. The adopted method is determined, taking account of the required semiconductor circuit characteristics, the maximum processing temperature of the substrate, and other factors. Then, a gate-insulating film **36** of silicon oxide having a thickness of 1200 Å was deposited by plasma CVD

or thermal CVD. Subsequently, gate electrodes/interconnects **37, 38** were formed from a crystalline silicon film having a thickness of 5000 Å. The gate electrodes/interconnects **37, 38** may be made from metals such as aluminum, tungsten, and titanium, or their silicides. Where metallic gate electrodes/interconnects **37, 38** are formed, their top or side surfaces may be coated with anodic oxide as disclosed in Japanese Patent Laid-Open Nos. 267667/1993 and 338612/1994. The material of the gate electrodes/interconnects **37, 38** is determined according to the required semiconductor circuit characteristics, the maximum processing temperature of the substrate, and other factors (FIG. 4(A)).

Thereafter, N- and P-type impurity ions were introduced into the islands of silicon **34** and **35** by self-aligned ion implantation or other method to form N-type regions **39** and P-type regions **40**. Then, an interlayer dielectric film **41** of silicon oxide having a thickness of 5000 Å was deposited by a well-known means. Contact holes were created in this interlayer dielectric film. Aluminum alloy interconnects **41–44** were formed (FIG. 4(B)).

A silicon nitride film **46** having a thickness of 2000 Å was deposited as a passivation film on the laminate by plasma CVD. Contact holes communicating with the output terminal lines **44** were formed in this passivation film. An ITO (indium-tin oxide) electrode **47** having a thickness of 1000 Å was formed by sputtering techniques. ITO is a transparent conductive oxide. A gold bump **48** having a diameter of about 50 µm and a height of 30 µm was mechanically formed on the ITO electrode **47**. The resulting circuit was cut into appropriate size, thus obtaining a stick crystal (FIG. 4(C)).

An electrode **50** was formed also from ITO to a thickness of 1000 Å on another substrate **49** of the liquid crystal display. In the present example, a substrate of polyethylene sulfite having a thickness of 0.3 mm was used. The substrate **31** of the stick driver was bonded to this substrate **49** under pressure. At this time, the electrodes **47** and **50** were electrically connected to each other via the bump **48** (FIG. 5(A)).

Then, an adhesive **51** to which a thermosetting organic resin was added was injected into the gap between the stick crystal **31** and the substrate **49** of the liquid crystal display. The adhesive may be applied to the surface of any one of the stick crystal **31** and the substrate **49** before they are bonded together under pressure.

The laminate was processed for 15 minutes in an oven filled with a nitrogen ambient at 120° C. In this way, electrical connection and mechanical bonding between the stick crystal **31** and the substrate **49** were completed. Before the bonding operation is completed in this way, a check may be done to see whether the electrical connection is satisfactory or not by the method disclosed in the above-cited Japanese Patent Laid-Open No. 14880/1995 (FIG. 5(B)).

The laminate processed in this way was allowed to stand in a stream of mixture gas of chlorine trifluoride (ClF<sub>3</sub>) and nitrogen. The flow rate of each of the chlorine trifluoride and nitrogen was 500 SCCM. The reaction pressure was 1 to 10 torr. The temperature was room temperature. It is known that halogenated fluorine such as chlorine trifluoride selectively etches silicon. On the other hand, oxides such as silicon oxide and ITO are hardly etched. Also with respect to aluminum, if a stable oxide coating is formed on an aluminum film, then reaction no longer progresses. Hence, the aluminum is not etched.

In the present example, materials which might be attacked by chlorine trifluoride are the peeling layer (silicon) **32**, the

islands of silicon **34, 35**, the gate electrodes/interconnects **37, 38**, the aluminum alloy interconnects **41–44**, and the adhesive **51**. These materials excluding the peeling layer **32** and the adhesive **51** are capped with silicon oxide and other materials and, therefore, chlorine trifluoride is unable to reach them. In practice, only the peeling layer **32** was selectively etched as shown in FIG. 5(C), thus forming voids **52**.

As time passed further, the peeling layer **32** was completely etched away, so that the bottom surface **53** of the buffer film **33** was exposed. Thus, the substrate **31** of the stick crystal was separated from the semiconductor circuit. With etching using chlorine trifluoride, the etching process came to a stop at the bottom surface of the buffer film and so the bottom surface **53** was quite flat (FIG. 5(D)).

In this manner, fabrication of the semiconductor integrated circuit on one substrate of the liquid crystal display was completed. The liquid crystal display is completed, using the substrate obtained in this way.

## EXAMPLE 2

The present example relates to a method (referred to as the roll-to-roll method) of successively fabricating filmy passive matrix liquid crystal displays. A production system for implementing the present example is shown in FIG. 6. The substrate material for obtaining the filmy liquid crystal displays may be selected from polyethylene sulfite, polycarbonate, and polyimide. Since polyethylene terephthalate and polyethylene naphthalate are polycrystalline plastics, they are not appropriate as liquid crystal materials which provide displays making use of polarization of light.

The production system shown in FIG. 6 is divided into two major parts: the upper portion and the lower portion. In the lower portion, a substrate on which color filters are formed is fabricated as a component of a liquid crystal display. In the upper portion, a counter substrate is manufactured. First, steps for fabricating the substrate on which the color filters are formed are described.

Color filters of the three primary colors (RGB) are printed on the surface of a film wound on a roll **71**. The color filters are formed, using three sets of rolls **72**. Where the manufactured liquid crystal displays are monochrome devices, this step is dispensed with. This step is referred to as color filter printing.

Then, an overcoat is printed to form a planarization film, using rolls **73**. The overcoat acts to planarize the surface which is made uneven by the formation of the color filters. A transparent resinous material may be used as the material of the overcoat. This step is referred to as printing of overcoat (planarization film).

Then, row (column) electrodes are printed in a desired pattern, using a conductive ink, by means of rolls **74**. This step is referred to as formation of electrodes.

Thereafter, an orientation film is printed, using rolls **75**. This step is referred to as printing of orientation film. The film is passed through a heating furnace **76** to bake and solidify the orientation film. This step is referred to as the baking of orientation film.

The film is then passed between rolls **77** to rub the surface of the orientation film. In this way, the orientation step is completed. This step is referred to as rubbing.

Then, a stick crystal is mounted on the substrate by a pressure connection device **78**. This step is referred to as mounting of the stick crystal. The laminate is passed through a heating furnace **79** to cure the adhesive. Thus, the bonding operation is completed. This step is referred to as curing of the adhesive.

In the present example, the peeling layer uses silicon, in the same way as in Example 1. Then, the peeling layer is etched by a chlorine trifluoride chamber **80** which is differentially pumped to prevent the chlorine trifluoride from leaking out. As a result, the substrate is peeled from the stick crystal. This step is referred to as peeling of the stick crystal.

Then, spacers are sprayed onto the filmy substrate by a spacer applicator **81**. This step is referred to as spraying of spacers. A sealing material is printed, using rolls **82**. The sealing material acts to bond together the two opposite substrates and to prevent the liquid crystal material from leaking from the space between the substrates. In the present example, the semiconductor circuit is rendered thinner than the spacing between the substrates to seal the outer surface of the semiconductor integrated circuit as shown in FIG. 3, as disclosed in the above-cited Japanese Patent Laid-Open No. 66413/1993. This step is referred to as printing of the sealant.

Subsequently, a liquid crystal material is dripped, using a liquid crystal dripper **83**. As a result, a liquid crystal material layer is formed on the filmy substrate. In this way, the substrate on the side of the color filters, or a color filter panel, is completed. These manufacturing steps are made to progress successively by rotating the various rolls.

Then, steps for manufacturing the counter substrate are described. Column (row) electrodes are formed in a desired pattern on the filmy substrate fed out of a roll **61** by means of rolls **62**. This step is referred to as formation of electrodes.

Thereafter, an orientation film is formed by printing techniques, using rolls **63**. This step is referred to as printing of the orientation film. The film is passed through a heating furnace **64** to bake and solidify the orientation film. This step is referred to as baking of the orientation film.

Then, the filmy substrate is passed between rolls **65** to orient the molecules of the liquid crystal material. This step is referred to as rubbing.

The stick crystal is mounted on the substrate by a pressure connection device **66**. This step is referred to as mounting of the stick crystal. The laminate is passed through a heating furnace **67** to cure the adhesive. This step is referred to as curing of the adhesive.

Then, the substrate of the stick crystal is peeled off by a chlorine trifluoride chamber **68**. This step is referred to as peeling of the stick crystal.

The filmy substrate undergone the steps described thus far is passed around a roll **69** and sent to next rolls **84**. The substrate having the color filters and the counter substrate are bonded together by the rolls **84**, thus forming a liquid crystal cell. This step is referred to as bonding.

The assembly is then heated by a heating furnace **85** to cure the sealing material. In this way, the bonding of the substrates is completed. This step is referred to as curing of the sealant.

The assembly is cut into desired dimensions by a cutter **86**, thus completing a filmy liquid crystal display. This step is referred to as cutting.

In the present invention, the kinds, the thickness, and the size of the substrates of the display device can be varied variously. For example, as described in Example 2, a liquid crystal display in the form of a quite thin film can be obtained. In this case, the display device may be curved along a curved surface and bonded to it. Furthermore, less restrictions are imposed on the kind of the substrates. As a consequence, a lightweight material having high shock resistance such as a plastic substrate may also be used. This improves the portability.

In addition, in the present invention, the semiconductor integrated circuit forming a driver circuit is peeled from its support substrate by a halogen-containing gas which is not in a plasma state. Therefore, destruction of the semiconductor integrated circuit which would normally be caused by plasma damage can be prevented. This leads to an improvement in the yield with which liquid crystal displays are manufactured.

Moreover, the driver circuit occupies less area and so the display device can be arranged relative to other devices with a greater degree of freedom. Typically, the driver circuit can be confined within a region only a few centimeters wide around the display surface. Therefore, the display device itself is quite simple and is a highly fashionable industrial product. It can find extensive application. Hence, the present invention is industrially quite advantageous.

What is claimed is:

1. A method of manufacturing an active matrix display device wherein said display device has a first substrate provided with a plurality of pixel electrodes and switching thin film transistors for switching said pixel electrodes, and a first electrode comprising a transparent conductive oxide, the method comprising the steps of:

forming a semiconductor film over a glass substrate;

crystallizing said semiconductor film;

patterning the crystallized semiconductor film into a plurality of semiconductor islands;

forming a plurality of thin film transistors using said semiconductor islands;

forming a driver circuit with said plurality of thin film transistors;

forming a passivation film over said driver circuit;

forming a second electrode comprising a transparent conductive oxide over said passivation film, said second electrode electrically connected to said driver circuit through a contact hole of said passivation film; attaching said glass substrate provided with said driver circuit to said first substrate so that said second electrode is electrically connected to said first electrode.

2. A method of manufacturing a display device comprising:

preparing at least one display substrate provided with first electrodes comprising a transparent conductive oxide;

forming a semiconductor film over a glass substrate;

crystallizing said semiconductor film formed over said glass substrate;

patterning the crystallized semiconductor film into a plurality of semiconductor islands;

forming a plurality of thin film transistors with said semiconductor islands for constituting a plurality of driver circuits;

forming a passivation film over said plurality of thin film transistors;

forming second electrodes comprising a transparent conductive oxide over said passivation film, said second electrodes electrically connected to said driver circuits through contact holes of said passivation film;

dividing said glass substrate to obtain at least one divided glass substrate wherein said divided glass substrate carries at least one of said driver circuits and at least one of said second electrodes thereon; and

attaching said divided glass substrate to a display substrate so that said at least one of the second electrodes is electrically connected to said first electrodes.

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3. A method according to claim 2 wherein said display device is a passive type liquid crystal device.

4. A method according to claim 2 wherein said display device is an active matrix type liquid crystal device.

5. A method according to claim 2 further comprising a step of removing the divided glass substrate from said display substrate.

6. A method of manufacturing a display device comprising:

preparing at least one display substrate provided with first electrodes wherein said display substrate comprises a plastic;

forming a semiconductor film over a glass substrate;

crystallizing said semiconductor film formed over said display substrate;

patterning the crystallized semiconductor film into a plurality of semiconductor islands;

forming a plurality of thin film transistors with said semiconductor islands as an active layer thereof for constituting a plurality of driver circuits;

forming a passivation film over said plurality of thin film transistors;

forming second electrodes over said passivation film, said second electrodes electrically connected to said driver circuits through contact holes of said passivation film;

dividing said glass substrate to obtain at least one divided glass substrate wherein said divided glass substrate carries at least one of said driver circuits thereon and at least one of said second electrodes; and

attaching said divided glass substrate to a display substrate so that said at least one of the second electrodes is electrically connected to said first electrodes,

wherein both of said first and second electrodes comprise a transparent conductive oxide.

7. A method according to claim 6 wherein said display device is a passive type liquid crystal device.

8. A method according to claim 6 further comprising a step of removing the divided glass substrate from said display substrate.

9. A method of manufacturing an active matrix type display device comprising:

preparing at least one display substrate provided with a plurality of pixel electrodes and switching thin film transistors for switching said pixel electrodes and first electrodes for supplying signals to said switching thin film transistors;

forming a semiconductor film over a glass substrate;

crystallizing said semiconductor film;

patterning the crystallized semiconductor film into a plurality of semiconductor islands;

forming a plurality of thin film transistors with said semiconductor islands as an active layer thereof for constituting a plurality of driver circuits;

forming a passivation film over said plurality of thin film transistors;

forming second electrodes over said passivation film, said second electrodes electrically connected to said driver circuits through contact holes of said passivation film;

dividing said glass substrate to obtain at least one divided glass substrate wherein said divided glass substrate carries at least one of said driver circuits thereon and at least one of said second electrodes; and

attaching said divided glass substrate to a display substrate so that said at least one of the second electrodes is electrically connected to at least one of said first electrodes,

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wherein both of said first and second electrodes comprise a transparent conductive oxide.

10. A method according to claim 9 further comprising a step of removing the divided glass substrate from said display substrate.

11. A method according to claim 9 wherein a thickness of said semiconductor islands is from 400 to 600 Å.

12. A method of manufacturing an active matrix type display device comprising:

preparing at least one display substrate provided with a plurality of pixel electrodes and switching thin film transistors for switching said pixel electrodes and first electrodes for supplying signals to said thin film transistors;

forming a semiconductor film over a glass substrate; crystallizing said semiconductor film wherein the crystallization is promoted by adding a catalyst to said semiconductor film;

patterning the crystallized semiconductor film into a plurality of semiconductor islands;

forming a plurality of thin film transistors with said semiconductor islands as an active layer thereof for constituting a plurality of driver circuits;

forming a passivation film over said plurality of thin film transistors;

forming second electrodes over said passivation film, said second electrodes electrically connected to said driver circuits through contact holes of said passivation film;

dividing said glass substrate to obtain at least one divided glass substrate wherein said divided glass substrate carries at least one of said driver circuits thereon and at least one of said second electrodes; and

attaching said divided glass substrate to a display substrate so that said at least one of the second electrodes is electrically connected to said first electrodes,

wherein both of said first and second electrodes comprise a transparent conductive oxide.

13. A method according to claim 12 further comprising a step of removing the divided glass substrate from said display substrate.

14. A method according to claim 12 wherein a thickness of said semiconductor islands is from 400 to 600 Å.

15. A method according to claim 12 wherein said catalyst comprises nickel.

16. A method of manufacturing a display device comprising:

preparing at least one display substrate provided with a plurality of first electrodes comprising a transparent oxide;

forming a semiconductor film over a glass substrate;

crystallizing said semiconductor film;

patterning the crystallized semiconductor film into a plurality of semiconductor islands;

forming a plurality of thin film transistors with said semiconductor islands as an active layer thereof for constituting a plurality of driver circuits;

forming a passivation film over the plurality of thin film transistors;

forming transparent electrodes over said passivation film wherein said transparent electrodes comprise a transparent conductive oxide;

forming metal bumps on said transparent electrodes;

dividing said glass substrate to obtain at least one divided glass substrate wherein said divided glass substrate carries at least one of said driver circuits thereon; and

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attaching said divided glass substrate to a display substrate so that said driver circuit is electrically connected to said first electrodes through said transparent electrodes and said metal bumps.

17. A method according to claim 16 further comprising a step of removing the divided glass substrate from said display substrate. 5

18. A method according to claim 16 wherein a thickness of said semiconductor islands is from 400 to 600 Å.

19. A method according to claim 16 wherein said passivation film comprises silicon nitride. 10

20. A method according to claim 16 wherein said display device is a passive type liquid crystal device.

21. A method according to claim 16 wherein said display device is an active matrix type liquid crystal device. 15

22. A method of manufacturing a display device comprising:

preparing at least one display substrate provided with a plurality of first transparent electrodes;

forming a semiconductor film over a glass substrate; 20

crystallizing said semiconductor film;

patterning the crystallized semiconductor film into a plurality of semiconductor islands;

forming a plurality of thin film transistors with said semiconductor islands as an active layer thereof for constituting a plurality of driver circuits; 25

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forming a passivation film over the plurality of thin film transistors;

forming second transparent electrodes over said passivation film wherein said transparent electrodes comprise a transparent conductive oxide;

dividing said glass substrate to obtain at least one divided glass substrate wherein said divided glass substrate carries at least one of said driver circuits thereon; and

attaching said divided glass substrate to a display substrate so that said driver circuit is electrically connected to said electrodes through said first and second transparent electrodes.

23. A method according to claim 22 wherein a thickness of said semiconductor islands is from 400 to 600 Å.

24. A method according to claim 22 wherein said display device is a passive type liquid crystal device.

25. A method according to claim 22 further comprising a step of removing the divided glass substrate from said display substrate so that said driver circuit remains connected to said electrodes. 20

26. A method according to claim 22 wherein said display device is a passive type liquid crystal device.

27. A method according to claim 22 wherein said display device is an active matrix type liquid crystal device.

\* \* \* \* \*

专利名称(译)	制造显示装置的方法，该显示装置具有连接到显示基板的驱动电路		
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#### 摘要(译)

一种制造驱动电路的方法，该驱动电路用于无源矩阵或有源矩阵电光显示装置，例如液晶显示器。驱动电路占用的空间比迄今为止少。具有基本上等于显示装置的矩阵的一侧的长度的长度的电路（棒状晶体）用作驱动电路。电路接合到显示装置的一个基板，然后电路的端子与显示装置的端子连接。随后，移除驱动器电路的基板。这使得电路的配置比迄今为止TAB方法或COG方法所要求的电路的配置简单得多，因为导线不是以复杂的方式布置的。驱动电路可以形成在诸如玻璃基板的大面积基板上。显示装置可以由具有高抗冲击性的轻质材料形成，例如塑料基板。因此，可以获得具有优异便携性的显示装置。

